

JUL 5 - 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	§	
Ji-Ung Lee et al.	§	
	§	Group Art Unit: 2884
Serial No.: 10/687,407	§	
	§	Examiner: Gabor, Otilia
Filed: October 14, 2003	§	
	§	
For: STORAGE CAPACITOR DESIGN	§	Atty. Docket: 126119-1
FOR A SOLID STATE IMAGER	§	
	§	
	§	

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

CERTIFICATE OF MAILING
37 C.F.R. 1.8

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the date below:

Date _____

AFFIDAVIT OF JI-UNG LEE, DOUGLAS ALBAGLI AND CHING-YEU WEI UNDER
37 C.F.R. §1.132

We, Ji-Ung Lee, Douglas Albagli and Ching-Yeu Wei, hereby state:

1. Our names are Ji-Ung Lee, Douglas Albagli and Ching-Yeu Wei, and our professional address is General Electric Global Research, One Research Circle, Niskayuna, New York 12309.

2. We are presently employed by General Electric Global Research in Niskayuna, New York as:

Ji-Ung Lee, *Packaging & Reliability Engineer;*

Douglas Albagli, *Physicist;*

Ching-Yeu Wei, *Physicist.*

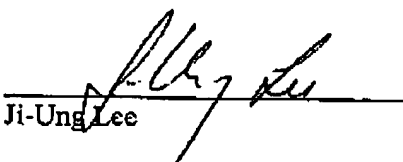
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Affidavit of Ji-Ung Lee et al.
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3. We are the joint inventors of U.S. Patent No. 6,740,884, and named co-inventors on the present patent application, Serial No. 10/687,407.

4. We hereby declare that any invention disclosed but not claimed in U.S. Patent No. 6,740,884 was made by us and is therefore not an invention "by another", and that any use of such in the present patent application was based upon our contribution to the presently claimed invention

We, individually, declare further that all statements made herein are of our own knowledge are true and that all statements made on information and belief are believed to be true, and further, that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under 18 U.S.C. §1001, and that such willful false statements may jeopardize the validity of the application, any patent issuing thereon, or any patent to which this verified statement is directed.

Dated: 6/22/2006

By: 
Ji-Ung Lee

Dated: 6/30/2006

By: 
Douglas Albagli

Dated: 6/22/2006

By: 
Ching-Yeu Wei